## Abstract Submitted for the DNP07 Meeting of The American Physical Society

The impact of the  ${}^{26}\text{Al}^m(\mathbf{p},\gamma)^{27}\text{Si}$  reaction rate on the destruction of  ${}^{26}\text{Al}$  in ONe novae<sup>1</sup> CATHERINE DEIBEL, Yale University, JAC CAGGIANO, PNL, JASON CLARK, Yale University, RACHEL LEWIS, University of York, ANUJ PARIKH, PETER PARKER, CHRISTOPHER WREDE, Yale University — Evidence of ongoing nucleosynthesis of  ${}^{26}\text{Al}$  ( $\tau_{1/2} = 7.2 \times 10^5 \text{ yr}$ ) in our galaxy has been observed in the form of the 1.809 MeV  $\gamma$ -ray resulting from  ${}^{25}\text{Mg}(\mathbf{p},\gamma)^{26}\text{Al}^{g.s.}(\beta^+\nu_e)^{26}\text{Mg}^*$  [1]. The  ${}^{25}\text{Mg}(\mathbf{p},\gamma)$  reaction can also produce  ${}^{26}\text{Al}^m$ , the short lived ( $\tau_{1/2} = 6.3 \text{ s}$ ), 0<sup>+</sup>, isomeric state of  ${}^{26}\text{Al}$ , which  $\beta^+$ -decays to  ${}^{26}\text{Mg}^{g.s.}$  only and must be treated separately from  ${}^{26}\text{Al}^{g.s.}$  at peak temperatures typical in novae (T<sub>9</sub>  $\approx .1 \cdot .35$ )[2]. Since  ${}^{26}\text{Al}(\mathbf{p},\gamma)^{27}\text{Si}$  competes with the  $\beta^+$ -decay of  ${}^{26}\text{Al}$  production. We have used the  ${}^{28}\text{Si}(\mathbf{p},\mathbf{d})^{27}\text{Si}$ ;  ${}^{28}\text{Si}({}^{3}\text{He},\alpha)^{27}\text{Si}^*(\mathbf{p})^{26}\text{Al}$ , and  ${}^{27}\text{Al}({}^{3}\text{He},t)^{27}\text{Si}^*(\mathbf{p})^{26}\text{Al}$  reactions to study the  ${}^{26}\text{Al}(\mathbf{p},\gamma)^{27}\text{Si}$  reaction. Several previously unpublished levels in  ${}^{27}\text{Si}$  and proton decay branching ratios will be reported. Their impact on the  ${}^{26}\text{Al}(\mathbf{p},\gamma)^{27}\text{Si}$  reaction rate and the nucleosynthesis of  ${}^{26}\text{Al}$  in ONe novae will be discussed.

[1] Diehl, R. et al., A&A, 449 (2006) 1025.

[2] Ward, R.A. and Fowler, W.A., ApJ, **238** (1980) 266.

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